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Substitute	for form 1449A/PTO	-		Complete if Known			
				Application Number	Not Known 10/705294		
INFO	RMATION D	ISC	LOSURE	Filing Date	11/10/2003		
STAT	EMENT BY	AP	PLICANT	First Named Inventor	Silver et al.		
				Group Art Unit	2625		
. (use as many sheets	as nec	cessary)	Examiner Name	D. Mariam		
Sheet 1 of 3		Attorney Docket Number	C97-050 CON3				

_				U.S. PATENT DOCUMEN	TS	
Examiner Initials*	Cite No.'	U.S. Patent Document Kind Code ² Number (<i>if known</i>)		Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	Pages, Columns, Lines, Where Relevant Passages or Relevant City Super Figures Appear
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Substitu	ite for form 1449	в/РТО		Complete if Known		
				Application Number	Not Known 10/705294	
INF	ORMATIO	N DISC	LOSURE	Filing Date	11/10/2003	
STATEMENT BY APPLICANT				First Named Inventor	Silver, et al.	
				Group Art Unit	2621	
(use as many sheets as necessary)				Examiner Name	D. Mariam	
Sheet 2 of 3				Attorney Docket Number	C97-050 CON3	

OTHER PRIO	R ART -	NON PATENT LITERATURE DOCUMENTS	7
Examiner Initials*	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ²
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Substit	tute for form 14	49B/PTO		Complete if Known			
				Application Number	Not Known 10/705294		
INF	ORMATI	ON DISC	CLOSURE	Filing Date	11/10/2003		
STA	ATEMEN	T BY AP	PLICANT	First Named Inventor	Silver et al.		
				Group Art Unit	2625		
	(use as man	y sheets as ne	cessary)	Examiner Name	D. Mariam		
Sheet	3	of	3	Attorney Docket Number	C97-050_CON3		

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